

# Fragmentation of clusters induced by collision with a solid surface: comparison of antimony and bismuth cluster ions

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**Abstract.** Mass-selected antimony cluster ions  $\text{Sb}_n^+$  ( $n = 3\text{--}12$ ) and bismuth cluster ions  $\text{Bi}_n^+$  ( $n = 3\text{--}8$ ) are allowed to collide with the surface of highly oriented pyrolytic graphite at energies up to 350 eV. The resulting fragment ions are analysed in a time-of-flight mass spectrometer. Two main fragmentation channels can be identified. At low impact energies both  $\text{Sb}_n^+$  and  $\text{Bi}_n^+$  cluster ions lose neutral tetramer and dimer units upon collision. Above about 150 eV impact energy  $\text{Sb}_3^+$  becomes the predominant fragment ion of all investigated antimony clusters. The enhanced stability of these fragment clusters can be explained in the framework of the polyhedral skeletal electron pair theory. In contrast,  $\text{Bi}_n^+$  cluster scattering leads to the formation of  $\text{Bi}_3^+$ ,  $\text{Bi}_2^+$  and  $\text{Bi}^+$  with nearly equal abundances, if the collision energy exceeds 75 eV. The integral scattering yield is substantially higher in this case as compared to  $\text{Sb}_n^+$  clusters.

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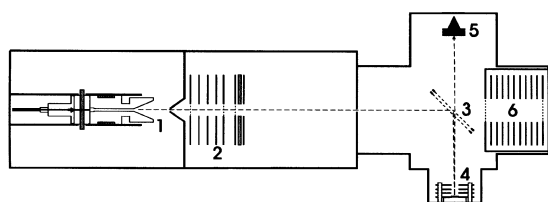
## Introduction

The understanding of the dynamical and energetical processes occurring during impact of metal clusters onto solid surfaces is important for thin film preparation via low energy cluster beam deposition methods as well as for the synthesis of new catalytic active materials consisting of adsorbed soft-landed clusters [1–5]. Cluster impact onto solid surfaces also opens a possibility to carry out chemical reactions under extreme temperature and pressure conditions [6, 7]. The energy dependence of fragment ion distributions generated by collision of a size-selected metal cluster with a solid surface gives information about cluster stability, cluster structure, fragmentation efficiency and energy transfer to the surface during collision. Surface scattering experiments at hyperthermal energies have been already performed with clusters consisting of non-conducting as well as semi-conducting elements [8–11]. In these cases the formation of stable fragment clusters is favoured. In contrast, surface collision induced dissociation of aluminium cluster anions is dominated by a stepwise loss of neutral atoms [12].

In this brief report, we present experimental results regarding the surface collision induced fragmentation of clusters consisting of semi-metallic elements. Time-of-flight mass spectrometry is used to record fragment ion abundance distributions of mass-selected positively charged antimony and bismuth clusters as a function of cluster size and impact energy.

## Experimental

To investigate mass-selected metal cluster ions colliding with a solid surface we use a newly developed time-of-flight mass spectrometer arrangement which is schematically depicted in Fig. 1. In brief, it consists of a three stage molecular beam apparatus in which the cluster ions are directly generated in the expansion chamber by means of a modified pulsed arc cluster ion source [13, 14]. The cluster beam enters the second chamber through a skimmer and the ions are accelerated by combined acceleration and focusing fields into a Wiley-McLaren type time-of-flight mass spectrometer [15]. Scattering and detection takes place in the third chamber. A bunch of cluster ions with equal mass to charge ratio is selected via a specifically designed pulsed electrostatic mirror and deflected by  $90^\circ$  to a suitable substrate. The substrate is preceded by a deceleration lens to control the energy of the incoming ions and to focus them onto the substrate. The cluster ions hit the surface and the electrostatic field in front of the surface serves to reaccelerate the scattered ions into a second time-of-flight arrangement. The collision products pass the mirror, which is now grounded, and reach the microchannelplate detector. Signal registration and accumulation is performed by a fast waveform digitiser (LeCroy 9450). The electrostatic mirror can be rotated, in order to allow us to deflect the beam also either directly to the microchannelplate detector for mass-analysis, or into a reflectron for higher mass resolution (see Fig. 1). The impact energies assigned to the fragment ion spectra correspond to the mean impact energies of the colliding cluster ions. The energy spread is  $\pm 40$  to  $\pm 100$  eV. The surface employed in these investigations is the (0001) basal plane of highly oriented pyrolytic graphite (HOPG). The substrate is cleaved in air prior to its installation inside the vacuum chamber.

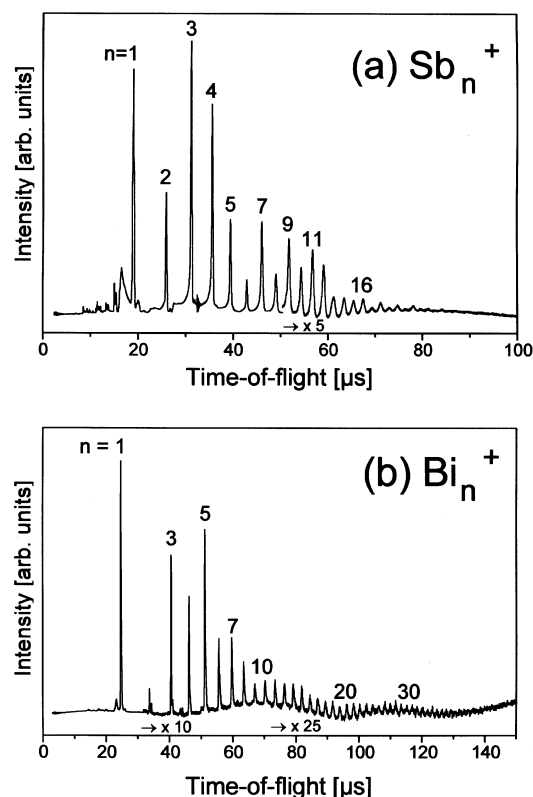


**Fig. 1.** Schematic drawing of the experimental setup: 1 cluster source, 2 acceleration and focusing, 3 rotatable electrostatic mirror, 4 scattering region (surface and preceding deceleration lens), 5 dual microchannelplate detector, 6 mass reflectron, the broken line gives the flight path of the ions in the scattering experiment

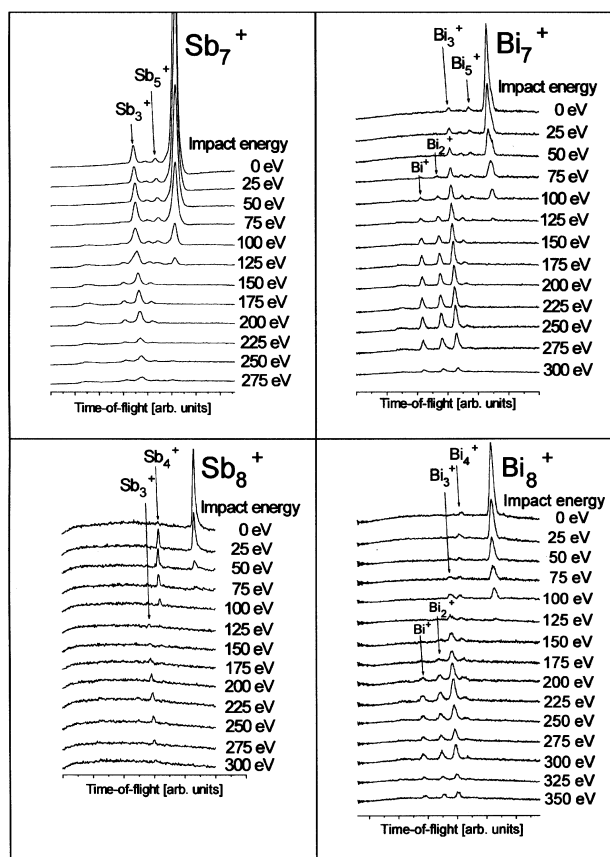
It is held at room temperature. The background pressure in the scattering region does not exceed  $10^{-7}$  mbar during the experiments.

## Results and discussion

Figure 2 shows mass spectra of positively charged antimony and bismuth clusters detected directly from the unscattered beam. The fragmentation mass spectra of  $X_n^+$  clusters ( $X = \text{Sb, Bi}$ ;  $n = 7, 8$ ) are shown in Fig. 3 as a function of impact energy. It can be seen, that no continuous fragment ion distributions are observed, instead specific cluster peaks clearly dominate the spectra. In the case of  $\text{Sb}_8^+$  and  $\text{Bi}_8^+$  these are the tetramer and the trimer fragments. The abundances of these fragment ions are plotted in Fig. 4 as a function of impact energy. At low impact energies for both  $\text{Sb}_8^+$  and  $\text{Bi}_8^+$  the  $X_4^+$  fragment predominates. This fragmen-

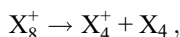


**Fig. 2a,b.** Mass spectra sampled from the unscattered beam: **a** antimony cluster cations; **b** bismuth cluster cations



**Fig. 3.** Fragmentation time-of-flight mass spectra for incident  $\text{Sb}_7^+$ ,  $\text{Bi}_7^+$ ,  $\text{Sb}_8^+$  and  $\text{Bi}_8^+$  cluster ions as a function of mean impact energy

tation is supposed to correspond to the unimolecular lowest energy dissociation channel



which was also observed in photodissociation (PD) [16], collision induced dissociation (CID) [17], and delayed fragmentation experiments [18].  $\text{Bi}_4$  and especially  $\text{Sb}_4$  are stable clusters, which is supported by the fact that they are present in the gas phase of the elements [19, 20]. The enhanced stability can be explained according to the predictions of the polyhedral skeletal electron pair theory (PSEPT) by the electronic structure of these clusters having an even number of valence electrons [21, 22]. Above a collision energy value of about 150 eV for  $\text{Sb}_8^+$  and 75 eV for  $\text{Bi}_8^+$  the  $X_3^+$  fragment becomes most abundant. It can be supposed that in this energy regime multiple fragmentation takes place with the result that the most stable ionic fragment cluster is formed. The particular stability of the  $X_3^+$  cluster ion was first inferred from mass-spectrometric studies of the intensity distributions of positively charged antimony and bismuth clusters from a laser vaporisation source [23]. A succinct explanation for this enhanced stability is also supplied by the PSEPT, which states a close relation between the electronic and the geometric structure of a series of homonuclear main group [24, 25] and transition metal clusters [26]. The theory predicts stability maxima for clusters with a specific number of valence electrons, namely of  $2n+2$  (closo-Wade-cluster;  $n$  = number of atoms in the cluster), of  $2n+4$  (nido-Wade-cluster), and

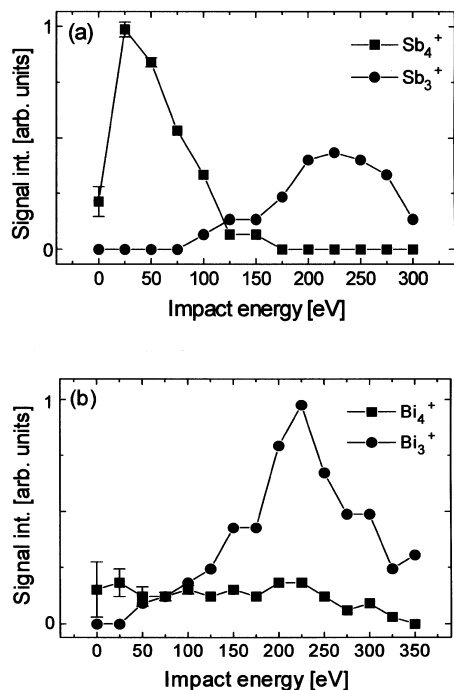


Fig. 4a,b. Intensities of the trimer and tetramer fragment ions for incident  $\text{Sb}_8^+$  a and  $\text{Bi}_8^+$  b clusters deduced from the corresponding mass spectra in Fig. 3. Error bars are drawn to account for the unknown amount of intact scattered cluster ions

of  $2n+6$  (arachno-Wade-cluster) electrons. The  $\text{Sb}_3^+$  and  $\text{Bi}_3^+$  clusters possess each eight valence electrons, hence the stable closo-structure can be assigned. Furthermore  $\text{X}_5^+$  and  $\text{X}_7^+$  are predicted to be of enhanced stability. This is supported by their pronounced appearance in the mass spectra of the unscattered beams of antimony and bismuth cluster cations (Fig. 2).

In Fig. 5 the fragment ion abundance patterns for all investigated clusters are summarised. The distributions shown in the part (a) of Fig. 5 correspond to the low energy scattering regime. Here the fragmentation spectra of the  $\text{Bi}_n^+$  clusters are in their general features similar to those of  $\text{Sb}_n^+$ . The unimolecular loss of neutral tetramer units is characteristic for incident clusters  $\text{X}_n^+$  with  $n > 6$  in this energy range, as already stated above. Additionally a sequential loss of neutral  $\text{X}_2$  units can be observed. For clusters with six and five atoms this is the predominant fragmentation channel.  $\text{Sb}_2$  and  $\text{Bi}_2$  are also stable species according to the PSEPT, and are present in the elemental vapours [19, 20]. For  $\text{X}_4^+$  the loss of one atom to form the  $\text{X}_3^+$  fragment is preferred. The part (b) of Fig. 5 reflects the typical fragmentation patterns resulting from the high energy impact of  $\text{X}_n^+$ . In the case of the investigated  $\text{Sb}_n^+$  the closo-cluster  $\text{Sb}_3^+$  is clearly the dominant fragment ion as predicted by the PSEPT. In contrast,  $\text{Bi}_n^+$  clusters strongly fragment to form the complete fragment ion series  $\text{Bi}_3^+$ ,  $\text{Bi}_2^+$ , and  $\text{Bi}^+$ , if the collision energy exceeds 75 eV. This cannot be understood in the framework of the PSEPT, because  $\text{Bi}_3^+$  should also have a closo-structure with enhanced stability.

The proposed mechanism for the surface collision induced dissociation in the investigated energy range is ion activation by vibrational excitation [27]. Our results can be

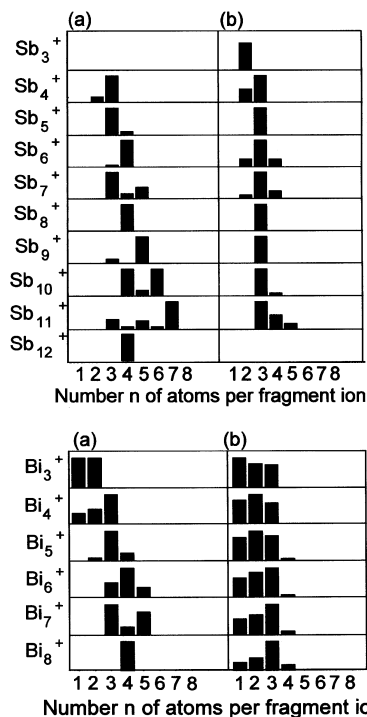


Fig. 5a,b. Normalised fragment ion abundance patterns of all investigated incident cluster ions at two different mean impact energies:  $\text{Sb}_n^+$ : a 75 eV, b 275 eV;  $\text{Bi}_n^+$ : a 25 eV, b 225 eV

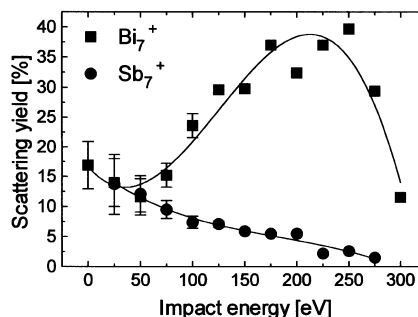


Fig. 6. Scattering yield plotted versus impact energy for the case of  $\text{Sb}_7^+$  and  $\text{Bi}_7^+$  collisions with graphite. The values are obtained from the corresponding total integrated signals in Fig. 3. The error bars reflect the uncertainty according to the unknown amount of intact scattered cluster ions

compared to low-energy CID measurements, because the fragmentation mechanism is also due to vibrational excitation and occurs on the ground state potential energy surface. Indeed, the lowest energy dissociation channels for  $\text{Sb}_n^+$  ( $n = 3-5$ ) and  $\text{Bi}_n^+$  ( $n = 3-14$ ) obtained by CID are in good agreement with our fragmentation data in the low energy regime [17].

An advantage of the surface induced dissociation technique over CID and PD techniques is the possibility to easily vary the collision energy. With increasing impact energy our data show fragmentation patterns for  $\text{Sb}_n^+$  and  $\text{Bi}_n^+$ , which were not detected neither in the low-energy CID experiment, nor in high-energy CID [17] or PD (248 nm [16], 193 nm [18]) measurements.

There is a further interesting difference in the scattering behaviour of antimony and bismuth. We find a higher in-

tegral scattering yield for all  $\text{Bi}_n^+$  clusters compared to the corresponding  $\text{Sb}_n^+$  clusters at collision energies exceeding 75 eV. This is shown in Fig. 6 for the impact of  $\text{X}_7^+$  clusters. At 200 eV collision energy the scattering yield integrated over all fragment ions is more than four times higher for  $\text{Bi}_7^+$  than for  $\text{Sb}_7^+$  clusters. Valence electron configuration arguments as supplied by the PSEPT are not sufficient to decide whether the stability of  $\text{Sb}_3^+$  compared to  $\text{Bi}_3^+$  could be the reason for the enhanced formation of  $\text{Bi}^+$  and  $\text{Bi}_2^+$  fragment ions as well as for the high overall scattering intensity for  $\text{Bi}_n^+$  compared to  $\text{Sb}_n^+$  clusters.

## Conclusion

We have shown that the surface induced fragmentation of positive antimony and bismuth clusters leads at low impact energies to the same fragmentation patterns for clusters of the same size. The main fragmentation channel is the ejection of neutral tetramers and dimers. The low energy fragmentation mechanisms were explained by the stability of the formed neutral tetramers and dimers as predicted by the PSEPT.

This theory is also applicable to explain the stability of  $\text{Sb}_3^+$ , which is the predominant high energy impact fragment for antimony clusters. At collision energies exceeding a specific value, which is characteristic for the element, the fragment ion distributions and scattering yields of  $\text{Sb}_n^+$  and  $\text{Bi}_n^+$  clusters differ substantially. Scattering of bismuth clusters yields  $\text{Bi}_3^+$ ,  $\text{Bi}_2^+$  and  $\text{Bi}^+$  with comparable abundances, but with a significant higher relative integral intensity. To understand the different fragmentation patterns of  $\text{Bi}_n^+$  and  $\text{Sb}_n^+$ , more detailed informations about the cluster energetics and the dynamics of the cluster-surface collision process are needed.

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